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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I ² C, IrDA, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, POR, PWM, WDT
Number of I/O	68
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.65V ~ 3.6V
Data Converters	A/D 28x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	80-LQFP
Supplier Device Package	80-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8al318atcx

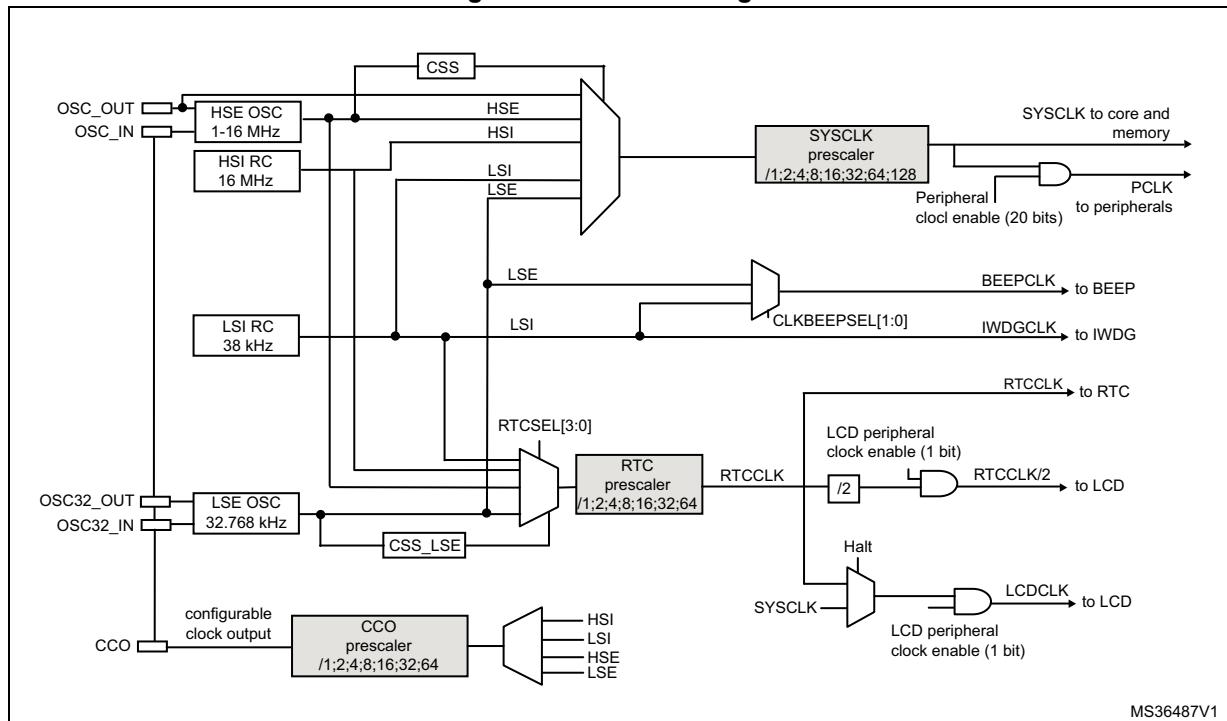
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Figure 2. Clock tree diagram



MS36487V1

1. The HSE clock source is either an external crystal/ceramic resonator or an external source (HSE bypass). Refer to Section HSE clock in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).
2. The LSE clock source is either an external crystal/ceramic resonator or a external source (LSE bypass). Refer to Section LSE clock in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).

3.5 Low-power real-time clock

The real-time clock (RTC) is an independent binary coded decimal (BCD) timer/counter.

Six byte locations contain the second, minute, hour (12/24 hour), week day, date, month, year, in BCD (binary coded decimal) format. Correction for 28, 29 (leap year), 30, and 31 day months are made automatically. The subsecond field is also readable in binary format.

The calendar is adjustable from 1 to 32767 RTC clock pulses. This allows to make a synchronization to a master clock.

The RTC offers a digital calibration which allows an accuracy of +/-0.5ppm.

It provides a programmable alarm and programmable periodic interrupts with wakeup from Halt capability.

- Periodic wakeup time using the 32.768 kHz LSE with the lowest resolution (of 61 µs) is from min. 122 µs to max. 3.9 s. With a different resolution, the wakeup time reaches 36 hours
- Periodic alarms based on the calendar are generated from LSE period to every year

A clock security system detects a failure on LSE, and provides an interrupt with wakeup capability. The RTC clock automatically switches to LSI in case of LSE failure.

The RTC also provides 3 anti-tamper detection pins. This detection embeds a programmable filter and wakes-up the MCU.

3.13.2 16-bit general purpose timers (TIM2, TIM3, TIM5)

- 16-bit autoreload (AR) up/down-counter
- 7-bit prescaler adjustable to fixed power of 2 ratios (1...128)
- 2 individually configurable capture/compare channels
- PWM mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)
- Synchronization with other timers or external signals (external clock, reset, trigger and enable)

3.13.3 8-bit basic timer (TIM4)

The 8-bit timer consists of an 8-bit up auto-reload counter driven by a programmable prescaler. This timer is used for timebase generation with interrupt generation on timer overflow or for DAC trigger generation.

3.14 Watchdog timers

The watchdog system is based on two independent timers providing maximum security to the applications.

3.14.1 Window watchdog timer

The window watchdog (WWDG) is used to detect the occurrence of a software fault, usually generated by external interferences or by unexpected logical conditions, which cause the application program to abandon its normal sequence.

3.14.2 Independent watchdog timer

The independent watchdog peripheral (IWDG) is used to resolve processor malfunctions due to hardware or software failures.

It is clocked by the internal LSI RC clock source, and thus stays active even in case of a CPU clock failure.

3.15 Beeper

The beeper function outputs a signal on the BEEP pin for sound generation. The signal is in the range of 1, 2 or 4 kHz.

3.16 Communication interfaces

3.16.1 SPI

The serial peripheral interfaces (SPI1 and SPI2) provide half/ full duplex synchronous serial communication with external devices.

- Maximum speed: 8 Mbit/s ($f_{SYSCLK}/2$) both for master and slave
- Full duplex synchronous transfers
- Simplex synchronous transfers on 2 lines with a possible bidirectional data line
- Master or slave operation - selectable by hardware or software
- Hardware CRC calculation
- Slave/master selection input pin

Note: SPI1 and SPI2 can be served by the DMA1 Controller.

3.16.2 I²C

The I²C bus interface (I2C1) provides multi-master capability, and controls all I²C bus-specific sequencing, protocol, arbitration and timing.

- Master, slave and multi-master capability
- Standard mode up to 100 kHz and fast speed modes up to 400 kHz.
- 7-bit and 10-bit addressing modes.
- SMBus 2.0 and PMBus support
- Hardware CRC calculation

Note: I²C1 can be served by the DMA1 Controller.

3.16.3 USART

The USART interfaces (USART1, USART2 and USART3) allow full duplex, asynchronous communications with external devices requiring an industry standard NRZ asynchronous serial data format. It offers a very wide range of baud rates.

- 1 Mbit/s full duplex SCI
- SPI1 emulation
- High precision baud rate generator
- Smartcard emulation
- IrDA SIR encoder decoder
- Single wire half duplex mode

Note: USART1, USART2 and USART3 can be served by the DMA1 Controller.

USART interfaces are used to implement LIN slave communication, with LIN Break detection on the framing error flag (FE in USART_SR register) with a value of 0 in the USART data register (USART_DR).

Table 5. High-density STM8AL3x8x pin description (continued)

Pin number			Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP80	LQFP64	LQFP48				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
5	1	1	PA0 ⁽⁸⁾ / <i>[USART1_CK]⁽²⁾</i> /SWIM/BEEP/IR_TIM ⁽⁹⁾	I/O	-	X	X	X	HS	X	X	Port A0	<i>[USART1 synchronous clock]⁽²⁾</i> / SWIM input and output / Beep output / Infrared Timer output
68	56	40	V _{SS2}	S	-	-	-	-	-	-	-		IOs ground voltage
67	55	39	V _{DD2}	S	-	-	-	-	-	-	-		IOs supply voltage
48	-	-	V _{SS4}	S	-	-	-	-	-	-	-		IOs ground voltage
47	-	-	V _{DD4}	S	-	-	-	-	-	-	-		IOs supply voltage

- At power-up, the PA1/NRST pin is a reset input pin with pull-up. To be used as a general purpose pin (PA1), it can be configured only as output open-drain or push-pull, not as a general purpose input. Refer to Section *Configuring NRST/PA1 pin as general purpose output* in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).
- [] Alternate function remapping option (if the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
- Available on STM8AL3L8x devices only.
- A pull-up is applied to PB0 and PB4 during the reset phase. These two pins are input floating after reset release.
- In the 5 V tolerant I/Os, the protection diode to V_{DD} is not implemented.
- In the open-drain output column, 'T' defines a true open-drain I/O (P-buffer, weak pull-up and protection diode to V_{DD} are not implemented).
- Available on STM8AL3L8x devices only. On STM8AL318x devices it is reserved and must be tied to V_{DD}.
- The PA0 pin is in input pull-up during the reset phase and after reset release.
- High Sink LED driver capability available on PA0.

Note: *The slope control of all GPIO pins, except true open drain pins, are programmable. By default the slope control is limited to 2 MHz.*

System configuration options

As shown in [Table 5: High-density STM8AL3x8x pin description](#), some alternate functions can be remapped on different I/O ports by programming one of the two remapping registers described in the "Routing interface (RI) and system configuration controller" section in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 509D	SYSCFG	SYSCFG_RMPCR3	Remapping register 3	0x00
0x00 509E		SYSCFG_RMPCR1	Remapping register 1	0x00
0x00 509F		SYSCFG_RMPCR2	Remapping register 2	0x00
0x00 50A0	ITC - EXTI	EXTI_CR1	External interrupt control register 1	0x00
0x00 50A1		EXTI_CR2	External interrupt control register 2	0x00
0x00 50A2		EXTI_CR3	External interrupt control register 3	0x00
0x00 50A3		EXTI_SR1	External interrupt status register 1	0x00
0x00 50A4		EXTI_SR2	External interrupt status register 2	0x00
0x00 50A5		EXTI_CONF1	External interrupt port select register 1	0x00
0x00 50A6	WFE	WFE_CR1	WFE control register 1	0x00
0x00 50A7		WFE_CR2	WFE control register 2	0x00
0x00 50A8		WFE_CR3	WFE control register 3	0x00
0x00 50A9		WFE_CR4	WFE control register 4	0x00
0x00 50AA	ITC - EXTI	EXTI_CR4	External interrupt control register 4	0x00
0x00 50AB		EXTI_CONF2	External interrupt port select register 2	0x00
0x00 50A9 to 0x00 50AF		Reserved area (7 byte)		
0x00 50B0	RST	RST_CR	Reset control register	0x00
0x00 50B1		RST_SR	Reset status register	0x01
0x00 50B2	PWR	PWR_CSR1	Power control and status register 1	0x00
0x00 50B3		PWR_CSR2	Power control and status register 2	0x00
0x00 50B4 to 0x00 50BF		Reserved area (12 byte)		
0x00 50C0	CLK	CLK_CKDIVR	Clock master divider register	0x03
0x00 50C1		CLK_CRTCR	Clock RTC register	0x00 ⁽¹⁾
0x00 50C2		CLK_ICKCR	Internal clock control register	0x11
0x00 50C3		CLK_PCKENR1	Peripheral clock gating register 1	0x00
0x00 50C4		CLK_PCKENR2	Peripheral clock gating register 2	0x00
0x00 50C5		CLK_CCOR	Configurable clock control register	0x00
0x00 50C6		CLK_ECKCR	External clock control register	0x00
0x00 50C7		CLK_SCSR	System clock status register	0x01
0x00 50C8		CLK_SWR	System clock switch register	0x01
0x00 50C9		CLK_SWCR	Clock switch control register	0xX0

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status	
0x00 521F to 0x00 522F		Reserved area (17 byte)			
0x00 5230	USART1	USART1_SR	USART1 status register	0xC0	
0x00 5231		USART1_DR	USART1 data register	0XX	
0x00 5232		USART1_BRR1	USART1 baud rate register 1	0x00	
0x00 5233		USART1_BRR2	USART1 baud rate register 2	0x00	
0x00 5234		USART1_CR1	USART1 control register 1	0x00	
0x00 5235		USART1_CR2	USART1 control register 2	0x00	
0x00 5236		USART1_CR3	USART1 control register 3	0x00	
0x00 5237		USART1_CR4	USART1 control register 4	0x00	
0x00 5238		USART1_CR5	USART1 control register 5	0x00	
0x00 5239		USART1_GTR	USART1 guard time register	0x00	
0x00 523A		USART1_PSCR	USART1 prescaler register	0x00	
0x00 523B to 0x00 524F		Reserved area (21 byte)			
0x00 5250	TIM2	TIM2_CR1	TIM2 control register 1	0x00	
0x00 5251		TIM2_CR2	TIM2 control register 2	0x00	
0x00 5252		TIM2_SMCR	TIM2 Slave mode control register	0x00	
0x00 5253		TIM2_ETR	TIM2 external trigger register	0x00	
0x00 5254		TIM2_DER	TIM2 DMA1 request enable register	0x00	
0x00 5255		TIM2_IER	TIM2 interrupt enable register	0x00	
0x00 5256		TIM2_SR1	TIM2 status register 1	0x00	
0x00 5257		TIM2_SR2	TIM2 status register 2	0x00	
0x00 5258		TIM2_EGR	TIM2 event generation register	0x00	
0x00 5259		TIM2_CCMR1	TIM2 capture/compare mode register 1	0x00	
0x00 525A		TIM2_CCMR2	TIM2 capture/compare mode register 2	0x00	
0x00 525B		TIM2_CCER1	TIM2 capture/compare enable register 1	0x00	
0x00 525C		TIM2_CNTRH	TIM2 counter high	0x00	
0x00 525D		TIM2_CNTRL	TIM2 counter low	0x00	
0x00 525E		TIM2_PSCR	TIM2 prescaler register	0x00	
0x00 525F		TIM2_ARRH	TIM2 auto-reload register high	0xFF	
0x00 5260		TIM2_ARRL	TIM2 auto-reload register low	0xFF	
0x00 5261		TIM2_CCR1H	TIM2 capture/compare register 1 high	0x00	

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53AC	DAC	DAC_DORH	DAC data output register high	0x00
0x00 53AD		DAC_DORL	DAC data output register low	0x00
0x00 53A2		DAC_DCH2RDHRH	DAC channel 2 right aligned data holding register high	0x00
0x00 53A3		DAC_DCH2RDHRL	DAC channel 2 right aligned data holding register low	0x00
0x00 53A4		DAC_DCH1LDHRH	DAC channel 1 left aligned data holding register high	0x00
0x00 53A5		DAC_DCH1LDHRL	DAC channel 1 left aligned data holding register low	0x00
0x00 53A6		DAC_DCH2LDHRH	DAC channel 2 left aligned data holding register high	0x00
0x00 53A7		DAC_DCH2LDHRL	DAC channel 2 left aligned data holding register low	0x00
0x00 53A8		DAC_DCH1DHR8	DAC channel 1 8-bit mode data holding register	0x00
0x00 53A9		DAC_DCH2DHR8	DAC channel 2 8-bit mode data holding register	0x00
0x00 53AA to 0x00 53AB		Reserved area (2 byte)		
0x00 53AC	DAC	DAC_CH1DORH Reset value	DAC channel 1 data output register high	0x00
0x00 53AD		DAC_CH1DORL Reset value	DAC channel 1 data output register low	0x00
0x00 53AE to 0x00 53AF		Reserved area (2 byte)		
0x00 53B0	DAC	DAC_CH2DORH Reset value	DAC channel 2 data output register high	0x00
0x00 53B1		DAC_CH2DORL Reset value	DAC channel 2 data output register low	0x00
0x00 53B2 to 0x00 53BF		Reserved area		
0x00 53C0	SPI2	SPI2_CR1	SPI2 control register 1	0x00
0x00 53C1		SPI2_CR2	SPI2 control register 2	0x00
0x00 53C2		SPI2_ICR	SPI2 interrupt control register	0x00
0x00 53C3		SPI2_SR	SPI2 status register	0x02
0x00 53C4		SPI2_DR	SPI2 data register	0x00
0x00 53C5		SPI2_CRCPR	SPI2 CRC polynomial register	0x07
0x00 53C6		SPI2_RXCRCR	SPI2 Rx CRC register	0x00
0x00 53C7		SPI2_TXCRCR	SPI2 Tx CRC register	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status	
0x00 53C8 to 0x00 53DF		Reserved area			
0x00 53E0	USART2	USART2_SR	USART2 status register	0xC0	
0x00 53E1		USART2_DR	USART2 data register	0xFF	
0x00 53E2		USART2_BRR1	USART2 baud rate register 1	0x00	
0x00 53E3		USART2_BRR2	USART2 baud rate register 2	0x00	
0x00 53E4		USART2_CR1	USART2 control register 1	0x00	
0x00 53E5		USART2_CR2	USART2 control register 2	0x00	
0x00 53E6		USART2_CR3	USART2 control register 3	0x00	
0x00 53E7		USART2_CR4	USART2 control register 4	0x00	
0x00 53E8		USART2_CR5	USART2 control register 5	0x00	
0x00 53E9		USART2_GTR	USART2 guard time register	0x00	
0x00 53EA		USART2_PSCR	USART2 prescaler register	0x00	
0x00 53EB to 0x00 53EF		Reserved area			
0x00 53F0	USART3	USART3_SR	USART3 status register	0xC0	
0x00 53F1		USART3_DR	USART3 data register	0xFF	
0x00 53F2		USART3_BRR1	USART3 baud rate register 1	0x00	
0x00 53F3		USART3_BRR2	USART3 baud rate register 2	0x00	
0x00 53F4		USART3_CR1	USART3 control register 1	0x00	
0x00 53F5		USART3_CR2	USART3 control register 2	0x00	
0x00 53F6		USART3_CR3	USART3 control register 3	0x00	
0x00 53F7		USART3_CR4	USART3 control register 4	0x00	
0x00 53F8		USART3_CR5	USART3 control register 5	0x00	
0x00 53F9		USART3_GTR	USART3 guard time register	0x00	
0x00 53FA		USART3_PSCR	USART3 prescaler register	0x00	
0x00 53FB to 0x00 53FF		Reserved area			

Table 10. CPU/SWIM/debug module/interrupt controller registers

Address	Block	Register label	Register name	Reset status
0x00 7F00	CPU ⁽¹⁾	A	Accumulator	0x00
0x00 7F01		PCE	Program counter extended	0x00
0x00 7F02		PCH	Program counter high	0x00
0x00 7F03		PCL	Program counter low	0x00
0x00 7F04		XH	X index register high	0x00
0x00 7F05		XL	X index register low	0x00
0x00 7F06		YH	Y index register high	0x00
0x00 7F07		YL	Y index register low	0x00
0x00 7F08		SPH	Stack pointer high	0x03
0x00 7F09		SPL	Stack pointer low	0xFF
0x00 7F0A		CCR	Condition code register	0x28
0x00 7F0B to 0x00 7F5F		Reserved area (85 byte)		
0x00 7F60	CPU	CFG_GCR	Global configuration register	0x00
0x00 7F70	ITC-SPR	ITC_SPR1	Interrupt Software priority register 1	0xFF
0x00 7F71		ITC_SPR2	Interrupt Software priority register 2	0xFF
0x00 7F72		ITC_SPR3	Interrupt Software priority register 3	0xFF
0x00 7F73		ITC_SPR4	Interrupt Software priority register 4	0xFF
0x00 7F74		ITC_SPR5	Interrupt Software priority register 5	0xFF
0x00 7F75		ITC_SPR6	Interrupt Software priority register 6	0xFF
0x00 7F76		ITC_SPR7	Interrupt Software priority register 7	0xFF
0x00 7F77		ITC_SPR8	Interrupt Software priority register 8	0xFF
0x00 7F78 to 0x00 7F79	Reserved area (2 byte)			
0x00 7F80	SWIM	SWIM_CSR	SWIM control status register	0x00
0x00 7F81 to 0x00 7F8F	Reserved area (15 byte)			

7 Option byte

Option byte contain configurations for device hardware features as well as the memory protection of the device. They are stored in a dedicated memory block.

All option byte can be modified in ICP mode (with SWIM) by accessing the EEPROM address. See [Table 12](#) for details on option byte addresses.

The option byte can also be modified ‘on the fly’ by the application in IAP mode, except for the ROP, UBC and PCODESIZE values which are only taken into account when they are modified in ICP mode (with the SWIM).

Refer to the STM8AL318x/STM8AL3L8x Flash programming manual (PM0054) and STM8 SWIM and Debug Manual (UM0470) for information on SWIM programming procedures.

Table 12. Option byte addresses

Address	Option name	Option byte No.	Option bits								Factory default setting			
			7	6	5	4	3	2	1	0				
00 4800	Read-out protection (ROP)	OPT0	ROP[7:0]								0xAA			
00 4802	UBC (User Boot code size)	OPT1	UBC[7:0]								0x00			
00 4807	PCODESIZE	OPT2	PCODE[7:0]								0x00			
00 4808	Independent watchdog option	OPT3 [3:0]	Reserved		WWDG _HALT	WWDG _HW	IWDG _HALT	IWDG _HW				0x00		
00 4809	Number of stabilization clock cycles for HSE and LSE oscillators	OPT4	Reserved		LSECNT[1:0]		HSECNT[1:0]					0x00		
00 480A	Brownout reset (BOR)	OPT5 [3:0]	Reserved		BOR_TH			BOR_ON				0x01		
00 480B	Bootloader option byte (OPTBL)	OPTBL [15:0]	OPTBL[15:0]								0x00			
00 480C											0x00			

9 Electrical parameters

9.1 Parameter conditions

Unless otherwise specified, all voltages are referred to V_{SS}.

9.1.1 Minimum and maximum values

Unless otherwise specified the minimum and maximum values are guaranteed in the worst conditions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at T_A = 25 °C and T_A = T_A max (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes and are not tested in production.

9.1.2 Typical values

Unless otherwise specified, typical data are based on T_A = 25 °C, V_{DD} = 3 V. They are given only as design guidelines and are not tested.

Typical ADC and DAC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range.

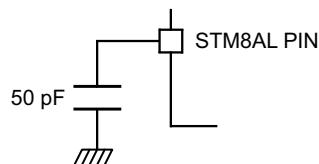
9.1.3 Typical curves

Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

9.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in [Figure 10](#).

Figure 10. Pin loading conditions



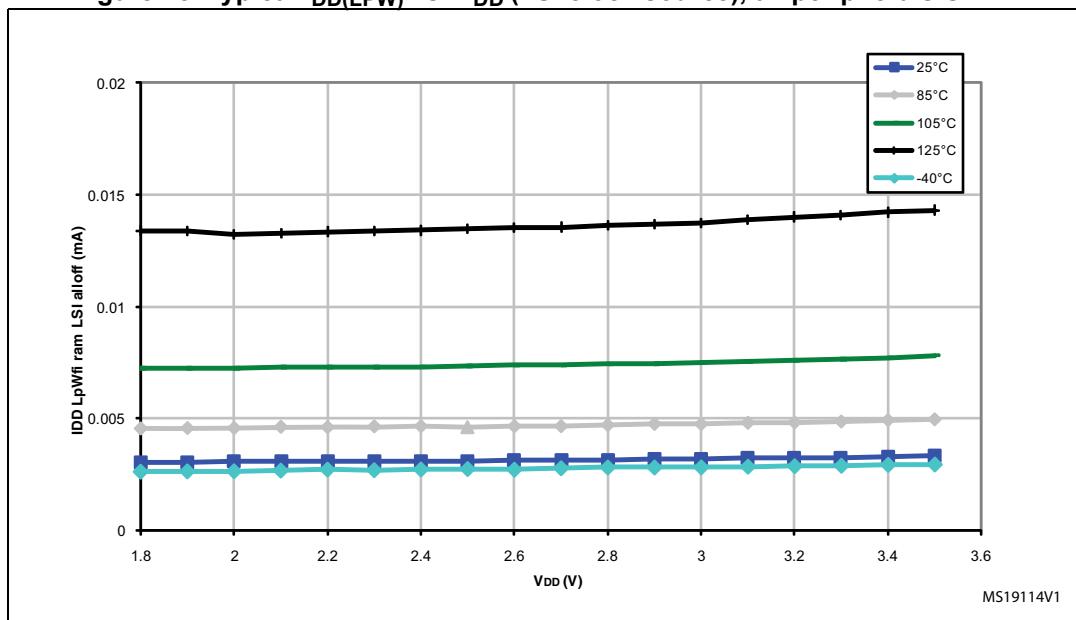
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Table 24. Total current consumption in low-power wait mode at $V_{DD} = 1.65 \text{ V}$ to 3.6 V

Symbol	Parameter	Conditions ⁽¹⁾		Typ.	Max.	Unit		
$I_{DD(LPW)}$	Supply current in low-power wait mode	LSI RC osc. (at 38 kHz)	all peripherals OFF	$T_A = -40 \text{ }^\circ\text{C}$ to $25 \text{ }^\circ\text{C}$	3.00	$3.30^{(2)}$		
				$T_A = 85 \text{ }^\circ\text{C}$	4.40	$9.00^{(3)}$		
	LSE external clock ⁽⁴⁾ (32.768 kHz)			$T_A = 125 \text{ }^\circ\text{C}$	11.00	$18.00^{(3)}$		
				$T_A = -40 \text{ }^\circ\text{C}$ to $25 \text{ }^\circ\text{C}$	2.35	$2.70^{(2)}$		
				$T_A = 85 \text{ }^\circ\text{C}$	3.10	$3.70^{(2)}$		
				$T_A = 125 \text{ }^\circ\text{C}$	12.0	$14.0^{(2)}$		

1. No floating I/Os.

2. Guaranteed by characterization results.

3. Tested at 85°C for temperature range A or 125°C for temperature range C.4. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption ($I_{DD LSE}$) must be added. Refer to [Table 33](#).**Figure 18. Typical $I_{DD(LPW)}$ vs. V_{DD} (LSI clock source), all peripherals OFF⁽¹⁾**

1. Typical current consumption measured with code executed from RAM.

Table 25. Total current consumption and timing in Active-halt mode at $V_{DD} = 1.65$ V to 3.6 V (continued)

Symbol	Parameter	Conditions ⁽¹⁾			Typ.	Max. ⁽²⁾	Unit
$t_{WU_HSI(AH)}^{(9)(10)}$	Wakeup time from Active-halt mode to Run mode (using HSI)	-	-	-	4.70	7.00	μs
$t_{WU_LSI(AH)}^{(9)(10)}$	Wakeup time from Active-halt mode to Run mode (using LSI)	-	-	-	150.0	-	μs

1. No floating I/O, unless otherwise specified.
2. Guaranteed by characterization results.
3. RTC enabled. Clock source = LSI
4. RTC enabled, LCD enabled with external $V_{LCD} = 3$ V, static duty, division ratio = 256, all pixels active, no LCD connected.
5. RTC enabled, LCD enabled with external V_{LCD} , 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
6. LCD enabled with internal LCD booster $V_{LCD} = 3$ V, 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
7. Oscillator bypassed (LSEBYP = 1 in CLK_ECKCR). When configured for external crystal, the LSE consumption (I_{DD_LSE}) must be added. Refer to [Table 33](#)
8. RTC enabled. Clock source = LSE
9. Wakeup time until start of interrupt vector fetch.
The first word of interrupt routine is fetched 4 CPU cycles after t_{WU} .
10. ULP=0 or ULP=1 and FWU=1 in the PWR_CSR2 register.

Table 26. Typical current consumption in Active-halt mode, RTC clocked by LSE external crystal

Symbol	Parameter	Condition ⁽¹⁾		Typ.	Unit
$I_{DD(AH)}^{(2)}$	Supply current in Active-halt mode	$V_{DD} = 1.8$ V	LSE	1.15	μA
			LSE/32 ⁽³⁾	1.05	
		$V_{DD} = 3$ V	LSE	1.30	
			LSE/32 ⁽³⁾	1.20	
		$V_{DD} = 3.6$ V	LSE	1.45	
			LSE/32 ⁽³⁾	1.35	

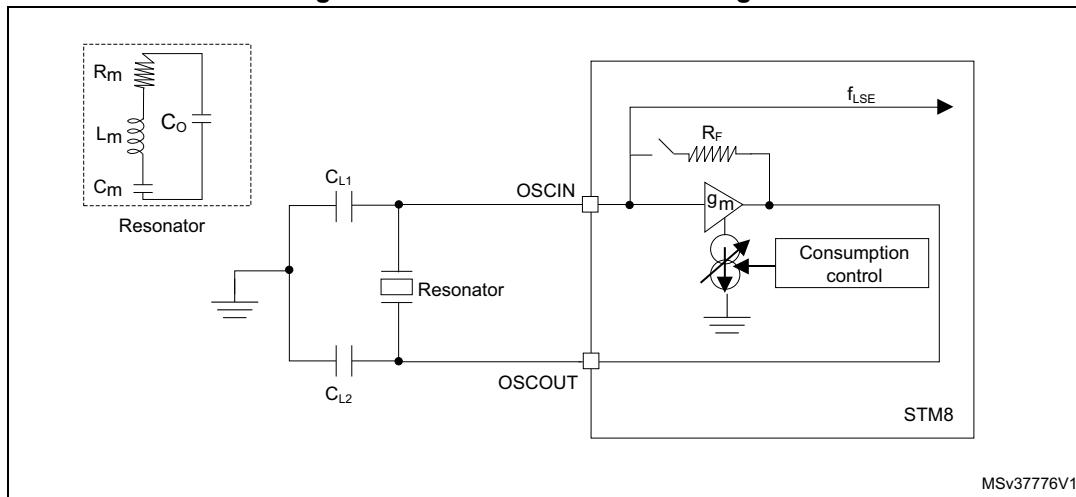
1. No floating I/O, unless otherwise specified.
2. Based on measurements on bench with 32.768 kHz external crystal oscillator.
3. RTC clock is LSE divided by 32.

Table 33. LSE oscillator characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
f_{LSE}	Low speed external oscillator frequency	-	-	32.768	-	kHz
R_F	Feedback resistor	$\Delta V = 200 \text{ mV}$	-	1.2	-	$M\Omega$
$C^{(1)(2)}$	Recommended load capacitance	-	-	8	-	pF
$I_{DD(LSE)}$	LSE oscillator power consumption	$V_{DD} = 1.8 \text{ V}$	-	450	-	nA
		$V_{DD} = 3 \text{ V}$	-	600	-	
		$V_{DD} = 3.6 \text{ V}$	-	750	-	
g_m	Oscillator transconductance	-	$3^{(3)}$	-	-	$\mu\text{A}/\text{V}$
$t_{SU(LSE)}^{(4)}$	Startup time	V_{DD} is stabilized	-	1	-	s

1. $C = C_{L1} = C_{L2}$ is approximately equivalent to 2 x crystal C_{LOAD} .
2. The oscillator selection can be optimized in terms of supply current using a high quality resonator with a small R_m value. Refer to crystal manufacturer for more details.
3. Guaranteed by design.
4. $t_{SU(LSE)}$ is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation. This value is measured for a standard crystal resonator and it varies significantly with the crystal manufacturer.

Figure 22. LSE oscillator circuit diagram



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Internal clock sources

Subject to general operating conditions for V_{DD} , and T_A .

High speed internal RC oscillator (HSI)

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

I²C - Inter IC control interface

Subject to general operating conditions for V_{DD}, f_{SYSCLK}, and T_A unless otherwise specified.

The STM8AL I²C interface (I2C1) meets the requirements of the Standard I²C communication protocol described in the following table with the restriction mentioned below:

Refer to I/O port characteristics for more details on the input/output alternate function characteristics (SDA and SCL).

Table 47. I²C characteristics

Symbol	Parameter	Standard mode I²C		Fast mode I²C⁽¹⁾		Unit
		Min.⁽²⁾	Max.⁽²⁾	Min.⁽²⁾	Max.⁽²⁾	
t _{w(SCL)}	SCL clock low time	4.7	-	1.3	-	μs
t _{w(SCLH)}	SCL clock high time	4.0	-	0.6	-	
t _{su(SDA)}	SDA setup time	250	-	100	-	ns
t _{h(SDA)}	SDA data hold time	0	-	0	900	
t _{r(SDA)} t _{r(SCL)}	SDA and SCL rise time	-	1000	-	300	ns
t _{f(SDA)} t _{f(SCL)}	SDA and SCL fall time	-	300	-	300	
t _{h(STA)}	START condition hold time	4.0	-	0.6	-	μs
t _{su(STA)}	Repeated START condition setup time	4.7	-	0.6	-	
t _{su(STO)}	STOP condition setup time	4.0	-	0.6	-	μs
t _{w(STO:STA)}	STOP to START condition time (bus free)	4.7	-	1.3	-	
C _b	Capacitive load for each bus line	-	400	-	400	pF

1. f_{SYSCLK} must be at least equal to 8 MHz to achieve max fast I²C speed (400 kHz).

2. Data based on standard I²C protocol requirement, not tested in production.

Note:

For speeds around 200 kHz, the achieved speed has a $\pm 5\%$ tolerance.

For other speed ranges, the achieved speed has a $\pm 2\%$ tolerance.

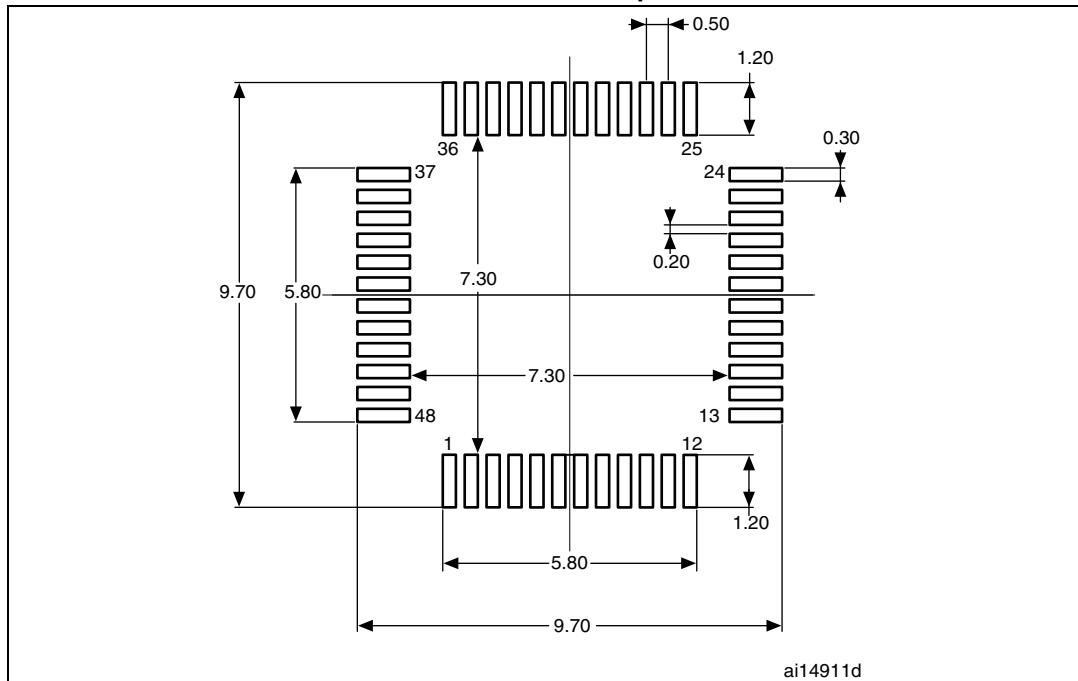
The above variations depend on the accuracy of the external components used.

Table 56. ADC1 characteristics (continued)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_S	Sampling time	V_{AIN} PF0/1/2/3 fast channels $V_{DDA} < 2.4$ V	0.43 ⁽³⁾⁽⁴⁾	-	-	μs
		V_{AIN} PF0/1/2/3 fast channels $2.4 \text{ V} \leq V_{DDA} \leq 3.6$ V	0.22 ⁽³⁾⁽⁴⁾	-	-	
		V_{AIN} on slow channels $V_{DDA} < 2.4$ V	0.86 ⁽³⁾⁽⁴⁾	-	-	
		V_{AIN} on slow channels $2.4 \text{ V} \leq V_{DDA} \leq 3.6$ V	0.41 ⁽³⁾⁽⁴⁾	-	-	
t_{conv}	12-bit conversion time	-	$12000000 / f_{ADC} + t_S$			
		16 MHz	1 ⁽³⁾	-	-	
t_{WKUP}	Wakeup time from OFF state	-	-	-	3	
$t_{IDLE}^{(5)}$	Time before a new conversion	-	-	-	∞	s
$t_{VREFINT}$	Internal reference voltage startup time	-	-	-	refer to Table 49	ms

1. The current consumption through V_{REF} is composed of two parameters:
 - one constant (max 300 μ A)
 - one variable (max 400 μ A), only during sampling time + 2 first conversion pulses.
So, peak consumption is $300+400 = 700$ μ A and average consumption is $300 + [(4 \text{ sampling} + 2) / 16] \times 400 = 450$ μ A at 1Msps
2. V_{REF-} must be tied to ground.
3. Minimum sampling and conversion time is reached for maximum $R_{AIN} = 0.5$ kΩ.
4. Value obtained for continuous conversion on fast channel.
5. In the RM0031, t_{IDLE} defines the time between 2 conversions, or between ADC ON and the first conversion. t_{IDLE} is not relevant for this device.

Figure 53. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package recommended footprint



1. Dimensions are expressed in millimeters.